

| | | | | |
|-----------------------------------|---------------------------------------|--|---|-------------|
| Notice of References Cited | Application/Control No. 10/658,681 | | Applicant(s)/Patent Under Reexamination HESS ET AL. | |
| | Examiner Joseph D. Pape | | Art Unit 3612 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------|----------------|
| | A | US-5,564,744 a | 10-1996 | Frost, Colin | 280/751 |
| | B | US-6,340,200 b1 | 01-2002 | Enomoto et al. | 296/187.09 |
| | C | US-5,575,500 a | 11-1996 | Mimura et al. | 280/751 |
| | D | US-5,163,730 a | 11-1992 | Welch, Jeffrey A. | 296/187.05 |
| | E | US-6,779,835 b2 | 08-2004 | Fox et al. | 296/187.05 |
| | F | US-3,773,373 | 11-1973 | McLauchlan, John | 293/135 |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.